Wafer Connector pitch 1mm series

1. Scope

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This specification covers the Wafer Connector FWF10003/FWF10004 Series

2. Ordering information

Refer to the drawing.

3. Connector dimensions

Refer to the drawing.

4. Material

Housing: PA9T (UL 94V-0)

Color: Natural
Terminal: Coppwr alloy
Plating: Gold plated
Solder tab: Copper alloy
Plating: Tin plated

5. Accommodated P.C.B layout

Refer to the drawing.

6. Rating

Operating voltage(Max.) 50V AC/DC Current rating(Max.) 1.0A AC/DC

Temperature range-operating -25°C -- +85°C(Including terminal temperature rese)

7. Performance

Test item	Requirement	Test Condition			
Electrical Performance					
Contact Resistance		Mate connectors, measure by dry circuit, 20mV MAX., 10mA. Mated Length: 50mm (AWG. #28) (Based upon JIS C5402 5.4)			
Insulation Resistance	100 MΩ Min.	Mate connectors, apply 500V DC between adjacent terminals or ground. (Based upon JIS C5402 5.2/MIL-STD-202 method 302 Cond.B)			
Dielectric Strength	No breakdown and flashove	Mate connectors, apply 500V AC for 1 minute between adjacent terminal or ground. (Based upon JIS C5402 5.1/MIL-STD-202 Method 301)			



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Test item	Requirement					Test Condition		
Contact resistance on crimped portion	10 mΩ Max.					Crimp the maximum applicable wire on to the terminal, measure by dry circuit, 20mV MAX., 10mA. Wire Length: 50mm (AWG. #28)		
			M	echani	cal Pe	rformance		
Insertion force and withdrawal force	Refer to paragraph 9					Insert and withdrawal connectors at the speed rate of 25± 3mm/minute		
Terminal/Housing Retention Force	0.5kgf Min.					Apply axial pull out force at the speed rate of 25±3mm/minute on the terminal assembled In the housing.		
	Wire size #28 #30 #32			#30	#32			
		width		0.7±0.1				
	1	height	0.58~ 0.62	0.55~ 0.60	0.45~ 0.58			
Crimping pull out Force	2	width		0.7	I	Fix the crimped terminal, apply axial pull out force on the wire at the speed rate of 25±3mm/minute		
		height	1.1 1.5kg	1	0.9	(Based upon JIS C5402 6.22)		
	Crin	Crimp strength		0.8kg min.	0.5kg min.			
	1. Conductor (mm) 2: Insulation (mm)							
Terminal Insertion Force	0.5kgf Max.					Insert the crimped terminal into the housing at the speed rate of 25±3mm/min.		
Pin Retention Force	0.5kgf Min.					Apply axial push force at the speed rate of 25±3mm/minute on the contact pin assembled in the base wafer.		
	<u>I</u>	En	vironm	nental F	Perforr	nance and others		
Heat resistance	Appearance No Damage			mage		Mated connector shall be placed in an oven for 96±4 hours a		
ineat resistance	Contact Resistance 40mΩ Max.			Max.		+85±2°C. (Based upon JIS C5402 7.8)		
Cold registeres	Appearance No Damage			mage		Mated connector shall be placed in a temperature chamber for 96±4 hours at -25±3°C (Based upon JIS C5402 7.9)		
Cold resistance	Contact Resistance 40mΩ Max.			Max.				
Humidity	Appear	pearance No Damage			Material composition should be a bread the self-self-self-self-self-self-self-self-			
	Contac	t Resistance	e 40mΩ Max.			Mated connector shall be placed in a humidity chamber on the following conditions. Temperature: 40±2°C Relative humidity: 90~95% Duration: 240 hours (Based upon MIL-STD-202 Method 103 Cond.A)		
	Dielect	ric Strength	250V,AC/min					
	Insulati	ion Resistance	e 10MΩ Min.			(Dasca aport Mile-01D-202 Metriod 103 Colla.A)		

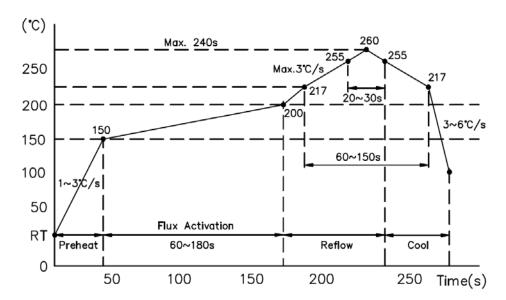


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Test item	Requirement		Test Condition	
Vibration	Appearance	No Damage	Amplitude: 1.52mm P.P Sweep time: 10-55-10Hz/minute Duration: 2 hours in each X、Y、Z axlals.	
	Contact Resistance	40mΩ Max.		
	Discontinuity 1µ sec Max.		(Based upon MIL-STD-202 method 201A)	
	Appearance	No Damage		
Shock	Contact Resistance 40mΩ Max.		50G, 3 strokes in each X、Y、Z. axlals. (Based upon JIS C0041)	
	Discontinuity	1μ sec Max.		
Temperature cycling	Appearance	No Damage	Mated connector shall be set to temperature cycling for 5	
	Contact Resistance	40mΩ Max.	cycles of which 1 cycle consists of: a). +25°C ~ 3minutes b)25°C ~ 30minutes	
	Dielectric Strength	500V,AC/min	c).+25°C ~ 3minutes d).+85°C ~ 30minutes	
	Insulation Resistance	10MΩ Min.	(Based upon JIS C5402 7.2)	
Temperature Rise	30°C Max.		Apply rated current load on mated connector in series- connection. Measure change of temperature on contact using thermocouples for 4 hours. (Based upon UL 1977)	
Repeated Insertion/ withdrawal	Contact Resistance	40mΩ Max.	Mate connector up to 30 cycles repeatedly at a rate of 10 cycles/minute. After which test the contact resistance	
Salt Spray	Appearance	No Damage	Mated connector shall be placed in a salt spray chamber on the following conditions. Salt Solution Density: 5±1%	
	Contact Resistance	40mΩ Max.	Temperature : 35±2°C Duration : 24±4 Hours (Based upon JIS C5402 7.1/MIL-STD-202 Method 101D Cond.B)	
Solderability	95% of immersed area must show no voids nor pin holes.		Immerse fluxed soldered section of contact pin into a solder bath for 3±0.5sec Temperature: 230±5°C	
Resistance to soldering heat	No Damage in appearance		Mated connector shall be dipped on solder bath for 5±0.5sec Temperature: 260±5°C	

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8. Reference infrared reflow condition



Standard JEDEC temperature profile (Lead free reflow)

9. Insertion force and withdrawal force

(Unit:kgf)

Circuits	Insertion (Max.)	Withdrawal (Min.)	
	Initial	Initial	30th
2	2.04	0.20	0.20
3	2.04	0.20	0.20
4	2.04	0.20	0.20
5	3.06	0.30	0.30
6	3.06	0.30	0.30
7	3.06	0.30	0.30
8	4.08	0.40	0.40
9	4.08	0.40	0.40
10	4.08	0.40	0.40
11	5.10	0.50	0.50
12	5.10	0.50	0.50
13	5.10	0.50	0.50
14	6.12	0.60	0.60
15	6.12	0.60	0.60